Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/667,740	BAILEY ET AL.
Examiner	Art Unit
TuyetLien (Lien) T. Tran	2179

SEARCHED				
Class	Subclass	Date	Examiner	
715	735	1/3/2006	π	
709	220	1/3/2006	тт	
709	221	1/3/2006	π	
709	222	1/3/2006	π	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCH	TES STRATEGY	)
	DATE	EXMR
Attached EAST search history and inventors name search	1/8/2006	π
Consulted with Ba Huynh	1/4/2006	тт